

<b>Search Notes</b> 				<b>Application/Control No.</b> 10/695,253 <b>Examiner</b> Yahveh Comas	<b>Applicant(s)/Patent under Reexamination</b> YIREN HONG <b>Art Unit</b> 2834
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>	
Class	Subclass	Date	Examiner	DATE	EXMR
310	51, 67r	3/4/2005	YC	Update search	7/24/2005
INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		